

A-Level Physics

Electron Microscopes

Question Paper

Time available: 65 minutes Marks available: 45 marks

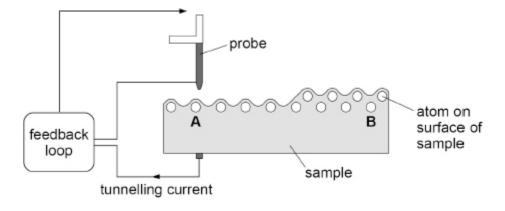
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| 1. | (a) | The scanning tunnelling microscope (STM) uses a process called quantum tunnelling. |
|----|-----|---|
| | | Explain what is meant by quantum tunnelling of an electron in an STM. You may include a diagram as part of your answer. |
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| | | |

(2)

(b) An STM is used to map the positions of the atoms between points **A** and **B** on the surface of a sample.

The diagram shows some of the features of the operation of an STM.

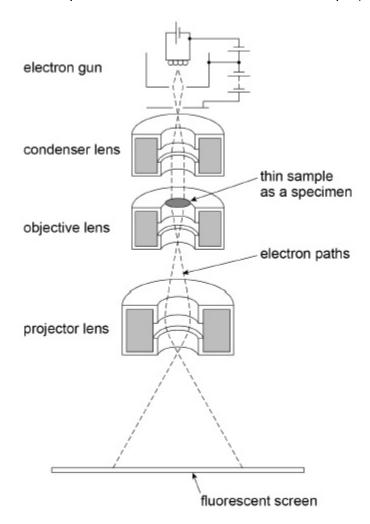


The STM in the diagram above is in constant-current mode.

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| ne smallest size of objects that the STM can resolve is similar to the de Broglie avelength of the tunnelling electrons. | |
| educe whether electrons with kinetic energies less than 1.5 eV are suitable to map turface in the diagram above. | the |
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2.

The diagram shows the main parts of a transmission electron microscope (TEM).



(a) What is the process by which electrons are produced in an electron gun? Tick (\checkmark) the correct box.

| Beta particle emission | 2 . |
|------------------------|-----|
| Electron diffraction | |
| Photoelectric effect | |
| Thermionic emission | S 5 |

(1)

| | gest, with a calculation, whether the images of individual atoms can, in principle, be |
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| eso | ved in this TEM. |
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| | pical TEM can accelerate electrons to very high speeds and form high resolution les. |
| xpl | ain: |
| | the process of image formation, and |
| | the factors that affect the quality of, and the level of detail in, the image. |
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- In a transmission electron microscope (TEM) electrons are accelerated by a potential difference V between a cathode and anode. The de Broglie wavelength λ of the accelerated electrons depends on V.
 - (a) Identify which of the following represents the relationship between λ and V. Ignore relativistic effects.

Tick (**√**) the correct answer in the right-hand column

| | ✓ if correct |
|--------------------------------------|--------------|
| $\lambda \propto \sqrt{\nu}$ | |
| $\lambda \propto V$ | |
| $\lambda \propto \frac{1}{V}$ | |
| $\lambda \propto \frac{1}{\sqrt{V}}$ | |

(1)

(b) TEMs operate using wavelengths of about 0.1 nm.

Explain why operation at such wavelengths makes the instrument such an important research tool.

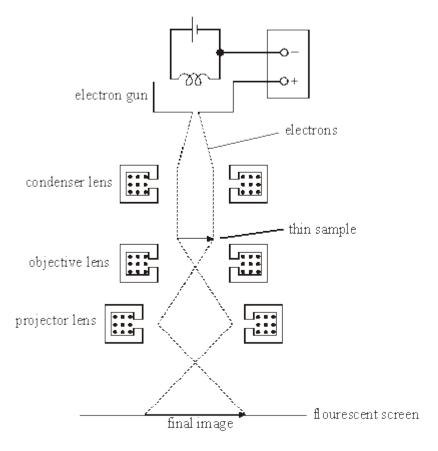
| | | |
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| | | |

(2)

| State and explain two factors that limit the detail in the image produce by a TEM. | |
|---|----------------|
| 1 | |
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| 2 | _ |
| 2 | _ |
| | _ |
| | _ |
| | _ (4) |
| | Total 7 marks) |

(c)

4. In a transmission electron microscope, electrons from a heated filament are accelerated through a certain potential difference and then directed in a beam through a thin sample. The electrons scattered by the sample are focused by magnetic lenses onto a fluorescent screen where an image of the sample is formed, as shown in the figure below.



| (a) | State and explain one reason why it is important that the electrons in the beam have the same speed. |
|-----|---|
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| | |

(2)

| (b) | When the potential difference is increased, a more detailed image is seen. Explain wh change happens. | y this |
|-----|--|---------------------|
| | | |
| | (To | (3) tal 5 marks) |
| | diagram shows the lens arrangement of a transmission electron microscope (T.E.M.). The led lines show two of the many paths followed by electrons through the T.E.M. | he |
| | electron gun | |
| | condenser lens thin sample being viewed | |
| | objective lens | |
| | third magnetic lens | |
| | fluorescent screen | |
| (a) | Complete the two electron paths on the diagram and draw an arrow to represent the fi image | nal |
| /b) | What is the function of | (2) |
| (b) | What is the function of | |
| | (i) the condenser lens, | |

5.

| (ii) | the objective lens, | |
|-------|---|-----------|
| (iii) | the third magnetic lens? | |
| | | |
| (i) | State and explain the effect on the resolving power of the T.E.M. if the anode very of the electron gun is increased. | oltage |
| | | |
| | | |
| (ii) | In practice, the resolving power of a T.E.M. is limited. State and explain one fact that limits the resolving power. | ctor |
| | | |
| | | otal 9 ma |

| | tip |
|---|---|
| | conducting surface |
| | The tip is made to scan the surface along a horizontal line. Describe and explain the effe on the current between the tip and the surface if the tip moves across a pit in the surface |
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| | |
| | An STM image can resolve individual atoms of diameter 0.5 nm on the surface. Estimate the kinetic energy, in eV, of an electron which has a de Broglie wavelength of 0.5 nm. |
|) | |
|) | |
|) | |
|) | |
|) | |

The diagram shows the tip of a scanning tunnelling microscope (STM) above a conducting

6.